DW PACKAGE

SCAS087A - APRIL 1993 - REVISED APRIL 1996

- Independent Registers and Enables for A and B Buses
- **Multiplexed Real-Time and Stored Data**
- Flow-Through Architecture Optimizes **PCB Layout**
- Center-Pin V_{CC} and GND Configurations Minimize High-Speed Switching Noise
- **EPIC™** (Enhanced-Performance Implanted CMOS) 1-µm Process
- 500-mA Typical Latch-Up Immunity at 125°C

description

This device consists of bus transceiver circuits, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the data bus or from the internal storage registers. Enable GAB and $\overline{G}BA$ are provided to control the transceiver functions. SAB and SBA control pins are provided to select whether real-time or stored data is transferred. The circuitry used for select control eliminates the typical decoding glitch that occurs in a multiplexer during the transition between stored and real-time data. A low input level selects real-time data, and a high selects stored data. Figure 1 illustrates the four fundamental bus-management functions that can be performed with the octal bus transceivers and registers.

(TOP VIEW) 28 CAB GAB 27 SAB A1 2 A2 3 26 II B1 25 B2 A3L A4 5 24**∏** B3 GND [23 B4 22 V_{CC} GND 21 🛮 V_{CC} GND GND 20 B5 19 B6 A5 🛛 10 11 18 **1** B7 A6 A7 12 17 ∏ B8 13 16 CBA A8 14 15 SBA GBA

Data on the A or B data bus, or both, can be stored in the internal D flip-flops by low-to-high transitions at the appropriate clock pins (CAB or CBA), regardless of the select or enable control pins. When SAB and SBA are in the real-time transfer mode, it is also possible to store data without using the internal D-type flip-flops by simultaneously enabling GAB and GBA. In this configuration, each output reinforces its input. Thus, when all other data sources to the two sets of bus lines are at high impedance, each set of bus lines remains at its last state.

The 74ACT11652 is characterized for operation from -40°C to 85°C.



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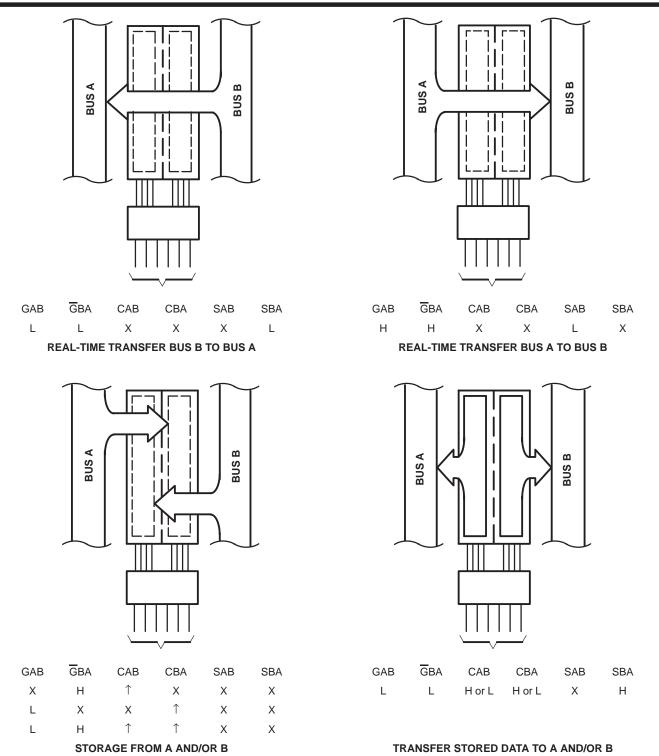


Figure 1. Bus Transfer Diagram

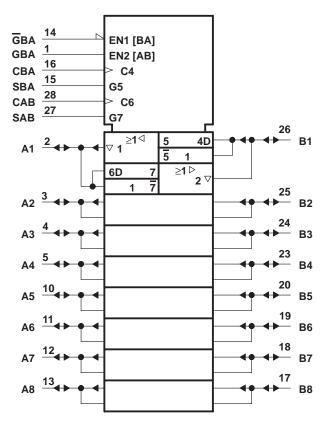


FUNCTION TABLE

		INF	PUTS			DATA	. I/O†	OPERATION OR FUNCTION
GAB	GBA	CAB	СВА	SAB	SBA	A1-A8	B1-B8	OPERATION OR FUNCTION
L	Н	H or L	H or L	Х	Х	lanut	lanut	Isolation
L	Н	↑	\uparrow	Х	X	Input	Input	Store A and B data
Х	Н	1	H or L	Х	Х	Input	Unspecified [†]	Store A, hold B
Н	Н	↑	\uparrow	χ‡	X	Input	Output	Store A in both registers
L	Х	H or L	↑	Х	Х	Unspecified [†]	Input	Hold A, store B
L	L	↑	\uparrow	Х	X‡	Output	Input	Store B in both registers
L	L	Х	Х	Х	L	Outrout	lanut	Real-time B data to A bus
L	L	Х	H or L	Х	Н	Output	Input	Stored B data to A bus
Н	Н	Х	Х	L	Х	lanut	Outenate	Real-time A data to B bus
Н	Н	H or L	Χ	Н	X	Input	Output	Stored A data to B bus
Н	L	H or L	H or L	Н	Н	Output	Output	Stored A data to B bus and stored B data to A bus

[†] The data-output functions may be enabled or disabled by various signals at the GAB or GBA inputs. Data-input functions are always enabled, i.e., data at the bus terminals is stored on every low-to-high transition on the clock inputs.

logic symbol§



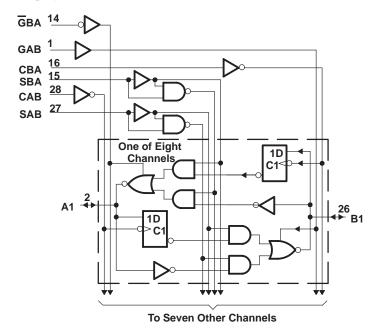
§ This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



[‡] Select control = L: clocks can occur simultaneously. Select control = H: clocks must be staggered to load both registers.

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logic diagram (positive logic)



absolute maximum rating over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)	0.5 V to V _{CC} + 0.5 V
Output voltage range, V _O (see Note 1)	
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±50 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND	±200 mA
Maximum power dissipation at $T_A = 55^{\circ}C$ (in still air) (see Note 2)	
Storage temperature range, T _{stq}	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions (see Note 3)

		MIN	MAX	UNIT
Vcc	Supply voltage	4.5	5.5	V
VIH	High-level input voltage	2		V
V _{IL}	Low-level input voltage		0.8	V
٧ _I	Input voltage	0	VCC	V
٧o	Output voltage	0	VCC	V
IOH	High-level output current		-24	mA
loL	Low-level output current		24	mA
Δt/ΔV	Input transition rise or fall rate	0	10	ns/V
TA	Operating free-air temperature	-40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.



NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

^{2.} The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DA DA	RAMETER	TEST CONDITIONS	Ves	T,	4 = 25°C	;	MIN	MAX	UNIT
	MAWIETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	IVIIIV	IVIAA	ONIT
		ΙΟΗ = – 50 μΑ	4.5 V	4.4			4.4		
		ΙΟΗ = - 30 μΑ	5.5 V	5.4			5.4		
Vон		Jan - 24 mA	4.5 V	3.94			3.8		V
		IOH = - 24 mA	5.5 V	4.94			4.8		
		$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V				3.85		
		La 50 uA	4.5 V			0.1		0.1	
		I _{OL} = 50 μA	5.5 V			0.1		0.1	V
VOL		1 24 mA	4.5 V			0.36		0.44	
		I _{OL} = 24 mA	5.5 V			0.36		0.44	
		$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V					1.65	
loz	A or B ports‡	$V_O = V_{CC}$ or GND	5.5 V			±0.5		±5	μА
ΙĮ	GAB or GBA	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1	μΑ
Icc		$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		80	μА
Δlccξ	3	One input at 3.4 V, Other inputs at GND or V _{CC}	5.5 V			0.9		1	mA
Ci	GAB or GBA	$V_I = V_{CC}$ or GND	5 V		4.5				pF
Co	A or B ports	$V_O = V_{CC}$ or GND	5 V		12				pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 2)

	PARAMETER	T _A = :	25°C	MIN	MAX	UNIT
	FARAMETER	MIN	MAX	IVIIIN		
fclock	Clock frequency	0	105	0	105	MHz
t _W	Pulse duration, CAB or CBA high or low	4.8		4.8		ns
t _{su}	Setup time, A before CLK↑ or B before CBA↑	4		4		ns
th	Hold time, A after CAB↑ or B after CBA↑	2.5		2.5		ns

[‡] For I/O ports, the parameter IOZ includes the input leakage current.

[§] This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or VCC.

74ACT11652 OCTAL BUS TRANSCEIVER AND REGISTER WITH 3-STATE OUTPUTS

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switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 2)

PARAMETER	FROM	то	T,	ղ = 25°C	;	MIN	MAX	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	IVIIIV		
f _{max}			105			105		MHz
^t PLH	A or B	B or A	3.8	7	9.9	3.8	11.1	ns
^t PHL	AUD	BULK	3.4	6.7	10.7	3.4	11.6	ns
t _{PLH}	CBA or CAB	A or B	5.4	8.4	11.8	5.4	13.1	no
t _{PHL}	CDA OI CAD	AUID	6.1	9.4	13.1	6.1	14.4	ns
^t PLH	SBA or SAB†	A or B	2.8	6.2	10.1	2.8	11	ns
^t PHL	with A or B high	AUID	5.5	8.7	12.1	5.5	13.3	115
^t PLH	SBA or SAB†	A or B	4.9	7.8	11	4.9	12.2	ns
^t PHL	with A or B low	AUID	3.9	7.5	11.6	3.9	12.6	113
^t PZH	GBA	А	3.3	7.2	11.4	3.3	12.6	ns
t _{PZL}	GBA	A	4.1	7.8	12.6	4.1	13.8	115
^t PHZ	GBA	А	5.2	7.2	9.3	5.2	9.9	no
t _{PLZ}	GBA	A	4.8	6.7	8.6	4.8	9.3	ns
^t PZH	GAB	В	5.1	9.1	13.4	5.1	15.2	no
^t PZL	GAB	Б	5.8	9.7	14.2	5.8	16.1	ns
t _{PHZ}	GAB	В	3.4	6.8	9.7	3.4	10.3	nc
t _{PLZ}	GAD	ט	3.1	6	8.8	3.1	9.3	ns

[†] These parameters are measured with the internal output state of the storage register opposite that of the bus input.

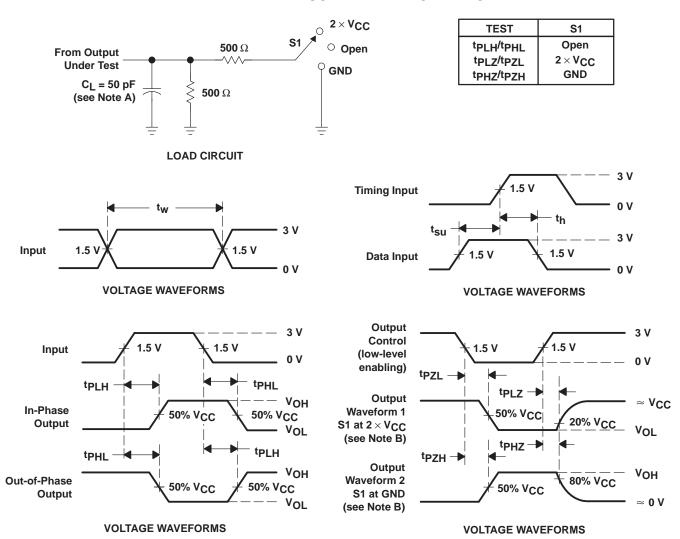
operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

	PARAMETER	TEST CO	TYP	UNIT		
<u> </u>	Dower discipation canacitance per transcriver	Outputs enabled	C 50 pE	f = 1 MHz	59	nE.
Cpd	Power dissipation capacitance per transceiver	Outputs disabled	$C_L = 50 \text{ pF},$	t = 1 MHz	14	p⊦



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PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50~\Omega$, $t_f = 3~ns$, $t_f = 3~ns$.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 2. Load Circuit and Voltage Waveforms





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PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
74ACT11652DW	ACTIVE	SOIC	DW	28	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ACT11652DWE4	ACTIVE	SOIC	DW	28	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ACT11652DWG4	ACTIVE	SOIC	DW	28	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ACT11652DWR	ACTIVE	SOIC	DW	28	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ACT11652DWRE4	ACTIVE	SOIC	DW	28	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ACT11652DWRG4	ACTIVE	SOIC	DW	28	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device		Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
74ACT11652DWR	SOIC	DW	28	1000	330.0	32.4	11.35	18.67	3.1	16.0	32.0	Q1



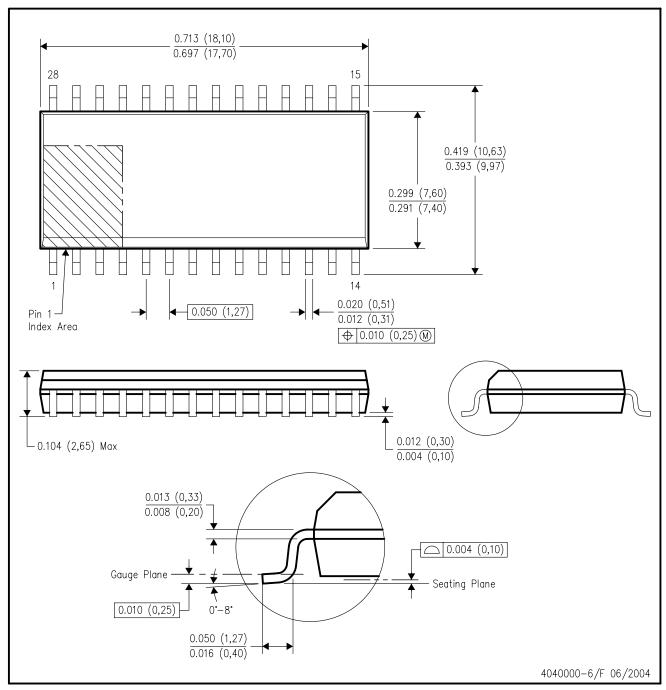


*All dimensions are nominal

Device		Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
74ACT11652E	WR	SOIC	DW	28	1000	346.0	346.0	49.0

DW (R-PDSO-G28)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AE.



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